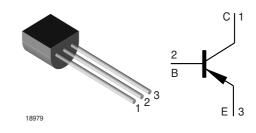




Small Signal Transistor (PNP)

Features

- PNP Silicon Epitaxial Planar Transistor for switching and amplifier applications.
- As complementary type, the NPN transistor 2N4401 is recommended.
- On special request, this transistor is also manufactured in the pin configuration TO-18.
- This transistor is also available in the SOT-23 case with the type designation MMBT4403.



Mechanical Data

Case: TO-92 Plastic case Weight: approx. 177 mg Packaging Codes/Options: BULK / 5 k per container 20 k/box TAP / 4 k per Ammopack 20 k/box

Parts Table

| Part | Type differentiation | Ordering code | Remarks |
|--------|----------------------|---------------------------|-----------------|
| 2N4403 | | 2N4403-BULK or 2N4403-TAP | Bulk / Ammopack |

Absolute Maximum Ratings

T_{amb} = 25 °C, unless otherwise specified

| Parameter | Test condition | Symbol | Value | Unit |
|-----------------------------|------------------------|--------------------|-------|-------|
| Collector - emitter voltage | | - V _{CEO} | 40 | V |
| Collector - base voltage | | - V _{CBO} | 40 | V |
| Emitter - base voltage | | - V _{EBO} | 5.0 | V |
| Collector current | | - I _C | 600 | mA |
| Power dissipation | T _A = 25 °C | P _{tot} | 625 | mW |
| | Derate above 25 °C | P _{tot} | 5.0 | mW/C° |
| | T _C = 25 °C | P _{tot} | 1.5 | W |
| | Derate above 25 °C | P _{tot} | 12 | mW/C° |

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Maximum Thermal Resistance

| Parameter | Test condition | Symbol | Value | Unit |
|--------------------------------------------|----------------|----------------|---------------|------|
| Thermal resistance junction to ambient air | | $R\theta_{JA}$ | 200 | °C/W |
| Thermal resistance junction to case | | $R\theta_{JC}$ | 83.3 | °C/W |
| Junction temperature | | Тj | 150 | °C |
| Storage temperature range | | Τ _S | - 55 to + 150 | °C |

Electrical DC Characteristics

| Parameter | Test condition | Symbol | Min | Тур | Max | Unit |
|---------------------------------------|-----------------------------------------------------|------------------------|------|-----|------|------|
| DC current gain | - V _{CE} = 1 V, - I _C = 0.1 mA | h _{FE} | 30 | | | |
| | - V _{CE} = 1 V, - I _C = 1 mA | h _{FE} | 60 | | | |
| | - V _{CE} = 1 V, - I _C = 10 mA | h _{FE} | 100 | | | |
| | - V _{CE} = 2 V, - I _C = 150 mA | h _{FE} | 100 | | 300 | |
| | - V _{CE} = 2 V, - I _C = 500 mA | h _{FE} | 20 | | | |
| Collector cut-off current | $- V_{EB} = 0.4 V, - V_{CE} = 35 V$ | - I _{CEV} | | | 100 | nA |
| Base cut-off current | $- V_{EB} = 0.4 V, - V_{CE} = 35 V$ | - I _{BEV} | | | 100 | nA |
| Collector - emitter saturation | - I _C = 150 mA, - I _B = 15 mA | - V _{CEsat} | | | 0.40 | V |
| voltage ¹⁾ | - I _C = 500 mA, - I _B = 50 mA | - V _{CEsat} | | | 0.75 | V |
| Base - emitter saturation | - I _C = 150 mA, - I _B = 15 mA | - V _{BEsat} | 0.75 | | 0.95 | V |
| voltage ¹⁾ | - I _C = 500 mA, - I _B = 50 mA | - V _{BEsat} | | | 1.30 | V |
| Collector - emitter breakdown voltage | - I _C = 1 mA, I _B = 0 | - V _{(BR)CEO} | 40 | | | V |
| Collector - base breakdown voltage | - I _C = 0.1 mA, I _E = 0 | - V _{(BR)CBO} | 40 | | | V |
| Emitter - base breakdown voltage | - I _E = 0.1 mA, I _C = 0 | - V _{(BR)EBO} | 5.0 | | | V |

 $^{1)}$ Pulse test: Pulse width \leq 300 μs - Duty cycle \leq 2 %.

Electrical AC Characteristics

| Parameter | Test condition | Symbol | Min | Тур | Max | Unit |
|------------------------------|---------------------------------------------------------------------------|-----------------|------------------------|-----|----------------------|------|
| Input impedance | - V _{CE} = 10 V, - I _C = 1 mA, | h _{ie} | 1.5 | | 15 | kΩ |
| | f = 1 kHz | | | | | |
| Voltage feedback ratio | $- V_{CE} = 10 V, - I_{C} = 1 mA,$ | h _{re} | 0.1 x 10 ⁻⁴ | | 8 x 10 ⁻⁴ | |
| | f = 1 kHz | | | | | |
| Current gain - bandwidth | $- V_{CE} = 10 \text{ V}, - I_{C} = 20 \text{ mA},$ | f _T | 200 | | | MHz |
| product | f = 100 MHz | | | | | |
| Collector - base capacitance | - $V_{CB} = 10 \text{ V}, \text{ f} = 1.0 \text{ MHz}, \text{ I}_{E} = 0$ | C _{CB} | | | 8.5 | pF |
| Emitter - base capacitance | $- V_{EB} = 0.5 V$, f = 1.0 MHz, I _C = 0 | C _{EB} | | | 30 | pF |
| Small signal current gain | - V _{CE} = 10 V, - I _C = 1 mA, | h _{fe} | 60 | | 500 | |
| | f = 1 kHz | | | | | |
| Output admittance | $- V_{CE} = 10 V$, $- I_{C} = 1 mA$, | h _{oe} | 1.0 | | 100 | μS |
| | f = 1 kHz | | | | | |

Switching Characteristics

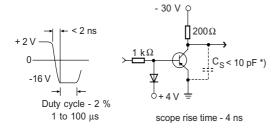
| Parameter | Test condition | Symbol | Min | Тур | Max | Unit |
|-----------|-----------------------------------------------------------------------------------------------------------------|----------------|-----|-----|-----|------|
| | - $I_{B1} = 15 \text{ mA}$, - $I_C = 150 \text{ mA}$, - $V_{CC} = 30 \text{ V}$, - $V_{EB} = 2 \text{ V}$ | t _d | | | 15 | ns |



2N4403

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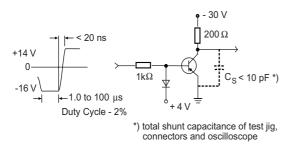
| Parameter | Test condition | Symbol | Min | Тур | Max | Unit |
|--------------------------|-------------------------------------------------------------------------------------------------------------------|----------------|-----|-----|-----|------|
| Rise time (see fig.1) | - $I_{B1} = 15 \text{ mA}$, - $I_{C} = 150 \text{ mA}$, - $V_{CC} = 30 \text{ V}$, - $V_{EB} = 2 \text{ V}$ | t _r | | | 20 | ns |
| Storage time (see fig.2) | - $I_{B1} = -I_{B2} = 15 \text{ mA},$ - $I_{C} = 150 \text{ mA}, - V_{CC} = 30 \text{ V}$ | t _s | | | 225 | ns |
| Fall time (see fig.2) | - $I_{B1} = -I_{B2} = 15 \text{ mA},$ - $I_{C} = 150 \text{ mA}, - V_{CC} = 30 \text{V}$ | t _f | | | 30 | ns |



*) total shunt capacitance of test jig, connectors and oscilloscope

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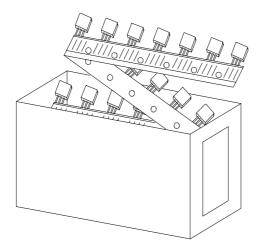


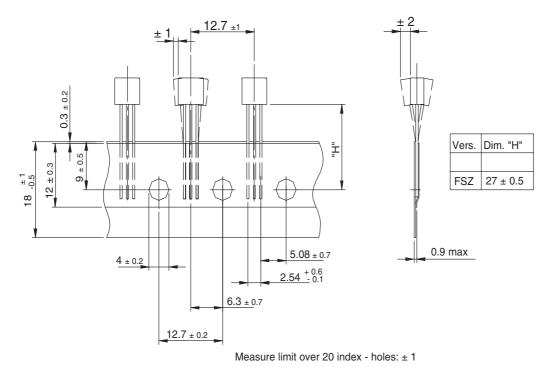
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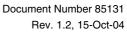
Packaging for Radial Taping

Dimensions in mm





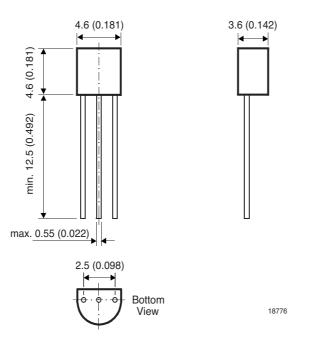
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Package Dimensions in mm (Inches)



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Ozone Depleting Substances Policy Statement

It is the policy of Vishay Semiconductor GmbH to

- 1. Meet all present and future national and international statutory requirements.
- 2. Regularly and continuously improve the performance of our products, processes, distribution and operatingsystems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

Vishay Semiconductor GmbH has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

- 1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
- 2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
- 3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

Vishay Semiconductor GmbH can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design and may do so without further notice.

Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use Vishay Semiconductors products for any unintended or unauthorized application, the buyer shall indemnify Vishay Semiconductors against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

Vishay Semiconductor GmbH, P.O.B. 3535, D-74025 Heilbronn, Germany Telephone: 49 (0)7131 67 2831, Fax number: 49 (0)7131 67 2423

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